International TOR Rectifier

IRF7101PbF

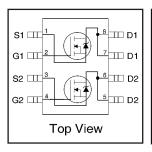
- Adavanced Process Technology
- Ultra Low On-Resistance
- Dual N-Channel MOSFET
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free

Description

Fourth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and dual-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

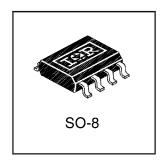
HEXFET® Power MOSFET



$$V_{DSS} = 20V$$

$$R_{DS(on)} = 0.10\Omega$$

$$I_D = 3.5A$$



Absolute Maximum Ratings

	Parameter	Max.	Units	
I _D @ T _A = 25°C	Continuous Drain Current, VGS @ 10V	3.5		
I _D @ T _A = 100°C Continuous Drain Current, V _{GS} @ 10V		2.3	A	
I _{DM}	Pulsed Drain Current ①	14		
P _D @T _C = 25°C	Power Dissipation	2.0	W	
	Linear Derating Factor	0.016	W/°C	
V_{GS}	Gate-to-Source Voltage	± 12	V	
dv/dt	Peak Diode Recovery dv/dt ②	3.0	V/nS	
T _{J,} T _{STG}	Junction and Storage Temperature Range	-55 to + 150	••	
	Sodering Temperature, for 10 seconds	300(1.6mm from case)	~ ℃	

Thermal Resistance Ratings

	Parameter	Min.	Тур.	Max	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient ④			62.5	°C/W

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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

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	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	20			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.025		V/°C	Reference to 25°C, I _D = 1mA
В	Static Drain-to-Source On-Resistance			0.10	Ω	V _{GS} = 10V, I _D = 1.8A ③
R _{DS(ON)}	Static Dialific-Source Off-Resistance			0.15	52	$V_{GS} = 4.5V, I_D = 1.0A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	1.0		3.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
g fs	Forward Transconductance	1.1			S	V _{DS} = 15V, I _D = 3.5A ③
	Drain-to-Source Leakage Current			2.0		$V_{DS} = 20V, V_{GS} = 0V$
IDSS	Diam-to-Source Leakage Current			250	μA	V_{DS} = 16V, V_{GS} = 0V, T_{J} = 125 °C
I _{GSS}	Gate-to-Source Forward Leakage	_	_	100	nA	V _{GS} = 12V
IGSS	Gate-to-Source Reverse Leakage			-100	11/4	V _{GS} = - 12V
Qg	Total Gate Charge			15		I _D = 1.8A
Q _{gs}	Gate-to-Source Charge			2.0	nC	V _{DS} = 16V
Q_{gd}	Gate-to-Drain ("Miller") Charge			3.6		V _{GS} = 10V
t _{d(on)}	Turn-On Delay Time		7.0			V _{DD} = 10V
t _r	Rise Time		10			I _D = 1.8A
t _{d(off)}	Turn-Off Delay Time		24		ns	$R_G = 8.2\Omega$
t _f	Fall Time		30			$R_D = 26\Omega$
L _D	Internal Drain Inductance		4.0		nH	Between lead,6mm(0.25in.)
L _S	Internal Source Inductance		6.0			from package and center of die contact
C _{iss}	Input Capacitance		320			V _{GS} = 0V
Coss	Output Capacitance		250		pF	V _{DS} = 15V
C _{rss}	Reverse Transfer Capacitance		75			f = 1.0MHz

Source-Drain Ratings and Characteristics

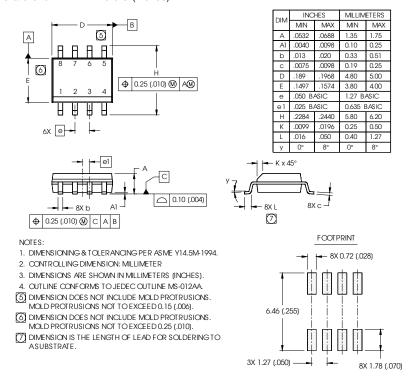
	Parameter	Min.	Тур.	Max.	Units	Conditions	
ls	Continuous Source Current			2.0	0.0	MOSFET symbol	
	(Body Diode)				Α	showing the	
I _{SM}	Pulsed Source Current				4.4		integral reverse
	(Body Diode) ①				14		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.2	V	$T_J = 25$ °C, $I_S = 1.7A$, $V_{GS} = 0V$ ③	
t _{rr}	Reverse Recovery Time		36	54	ns	T _J = 25°C, I _F = 1.7A	
Q _{rr}	Reverse RecoveryCharge		41	62	nC	di/dt = 100A/µs ③	
t _{on}	Forward Turn-On Time	Intr	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)				

Notes:

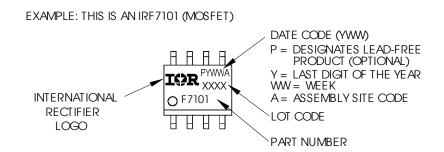
- ① Repetitive rating; pulse width limited by max. junction temperature.
- $\begin{tabular}{ll} \mathbb{Q} & $I_{SD} \leq 3.5A, \ di/dt \leq 90A/\mu s, \ $V_{DD} \leq V_{(BR)DSS},$ \\ $T_J \leq 150 ^{\circ}C$ \end{tabular}$
- 4 Surface mounted on FR-4 board, $t \leq 10 sec.$

SO-8 Package Outline

Dimensions are shown in milimeters (inches)



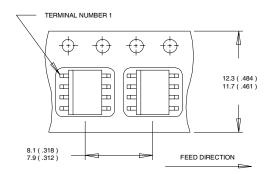
SO-8 Part Marking Information (Lead-Free)



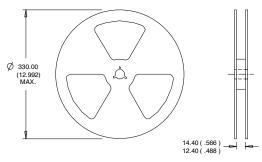
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SO-8 Tape and Reel

Dimensions are shown in milimeters (inches)



- NOTES:
 1. CONTROLLING DIMENSION: MILLIMETER.
 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- NOTES:
 1. CONTROLLING DIMENSION: MILLIMETER.
 2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualifications Standards can be found on IR's Web site.

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